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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/748,221	SUH ET AL.	
Examiner	Art Unit	
Brian Young	2819	

SEARCHED			
Class	Subclass	Date	Examiner
341	106, 107,68	7/25/2005	BY
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
341	106, 107	7/25/2005	ВҮ		
341	68	7/25/2005	BY		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
EAST (JPO,EPO,attached) , NPL (IEEE, portal) attached)	7/25/2005	BY	
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